Notice of References Cited Application/Control No. 10/537,099 Applicant(s)/Patent Under Reexamination VAN DE BOVENKAMP, ANTONIE Examiner DAVID H. BANH Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,453,955 A	07-1969	ANDERSON ROBERT J; et. al.	101/216
*	В	US-3,760,720 A	09-1973	Marshall et al.	101/157
*	С	US-4,222,325 A	09-1980	Edwards, Robert	101/137
*	D	US-5,109,768 A	05-1992	Lubke et al.	101/153
*	Е	US-5,123,346 A	06-1992	Schneider, Georg	101/148
*	F	US-5,301,609 A	04-1994	Guaraldi et al.	101/216
*	G	US-5,603,262 A	02-1997	Uera et al.	101/350.5
*	Ι	US-5,662,038 A	09-1997	Schaum et al.	101/76
*	ı	US-6,412,409 B2	07-2002	Weishew, Joseph J.	101/216
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 02009636 A	01-1990	Japan	TAO et al.	
	0					
	Р					
	α					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	NON-I ATENT BOODMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.